



Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L DEKRA 17.0001-01

CB Certificate No.: DEKRA-C10B

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1. Environmental and Reliability Testing of Electronic Components, Assemblies, and Related Materials

Description test	Standard	Remarks
Accelerated environment reliability stress tests (Including: Pre-condition test/ MSL test/ Accelerated Temperature-Humidity test / Temperature-Humidity with bias test / Temperature Cycling test / Power and temperature cycling / Temperature storage test / Salt)	JESD 47 J-STD-020 JESD22-series IEC-60068-series MIL-STD-202/750/810/883 JESDJP001 EIA-364-32C EIAJED-4701 AEC-Q100 AEC-Q101 AEC-Q200	Or customer specified test

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